

Molecular Devices: A Potential Replacement for Semiconductors

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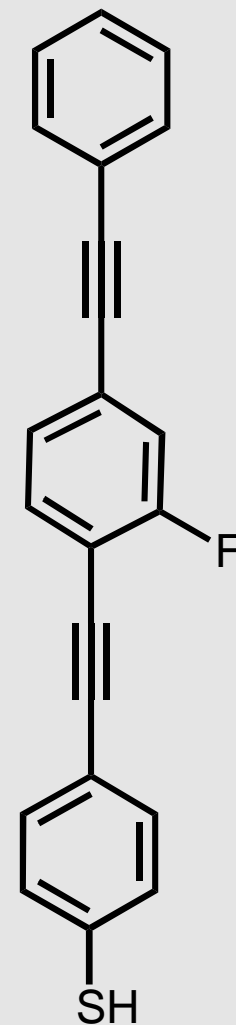
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Introduction

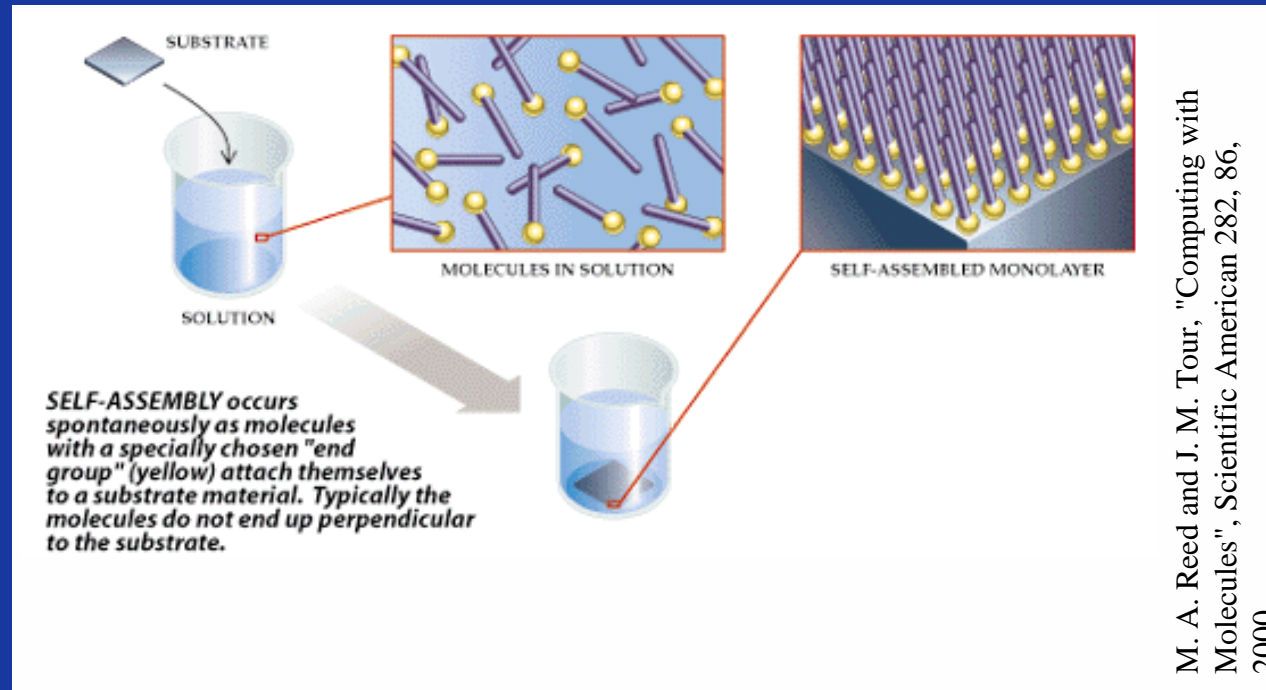
- Si and other semiconductor devices
 - Lower limit to size will soon be reached
- If successful, molecular electronics will allow much smaller devices to be constructed
 - molecules used are roughly $20 \times 10 \text{ \AA}$

The Molecule

- 2-fluoro-4-phenylethynyl-1-[(4-acetylthio)-phenylethynyl] benzene
 - Theorized that the molecule changes states when a voltage is applied
 - This property should allow the molecule to be used in the construction of electronic devices

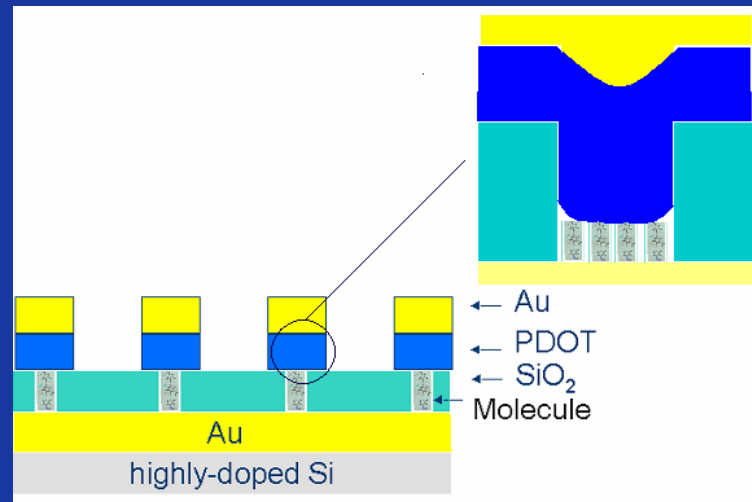


Self Assembly



- How do you attach electrodes to the end of a molecule?
- Self assembles on Au

Electrical Contact With Molecule



- Doped Si wafer, layer of Au, layer of oxide
- Nanobuckets in oxide layer
- poly(ethylenedioxythiophene) (PDOT) , a conducting polymer, spun on wafer
- Au dots evaporated onto PDOT
- Etch PDOT around Au dots

Optimizing PDOT

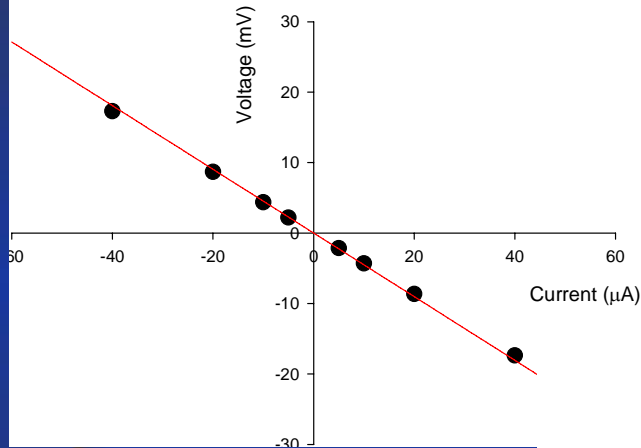
PDOT spinning

5s at 400 rpm

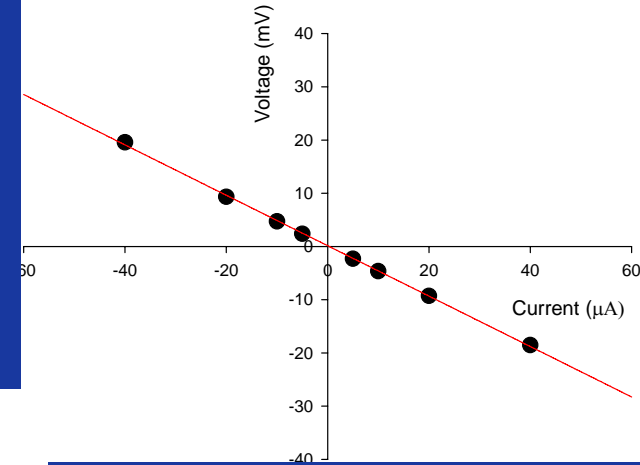
45 s at 2000 rpm

Baked at 50°C in vacuum oven

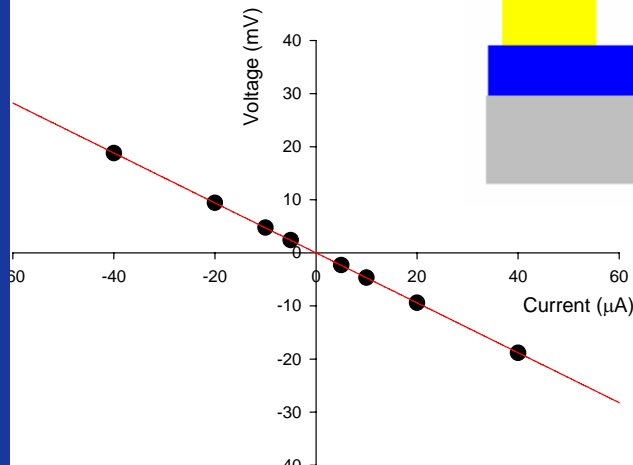
Current vs Voltage
(Wafer with P-dot and Gold, 3hrs)
#2
436 Ω



Current vs Voltage
(Wafer with P-dot and Gold, 6 hrs)
#3
474 Ω



Current vs Voltage
(Wafer with P-dot and Gold, 12 hrs)
#4
470 Ω



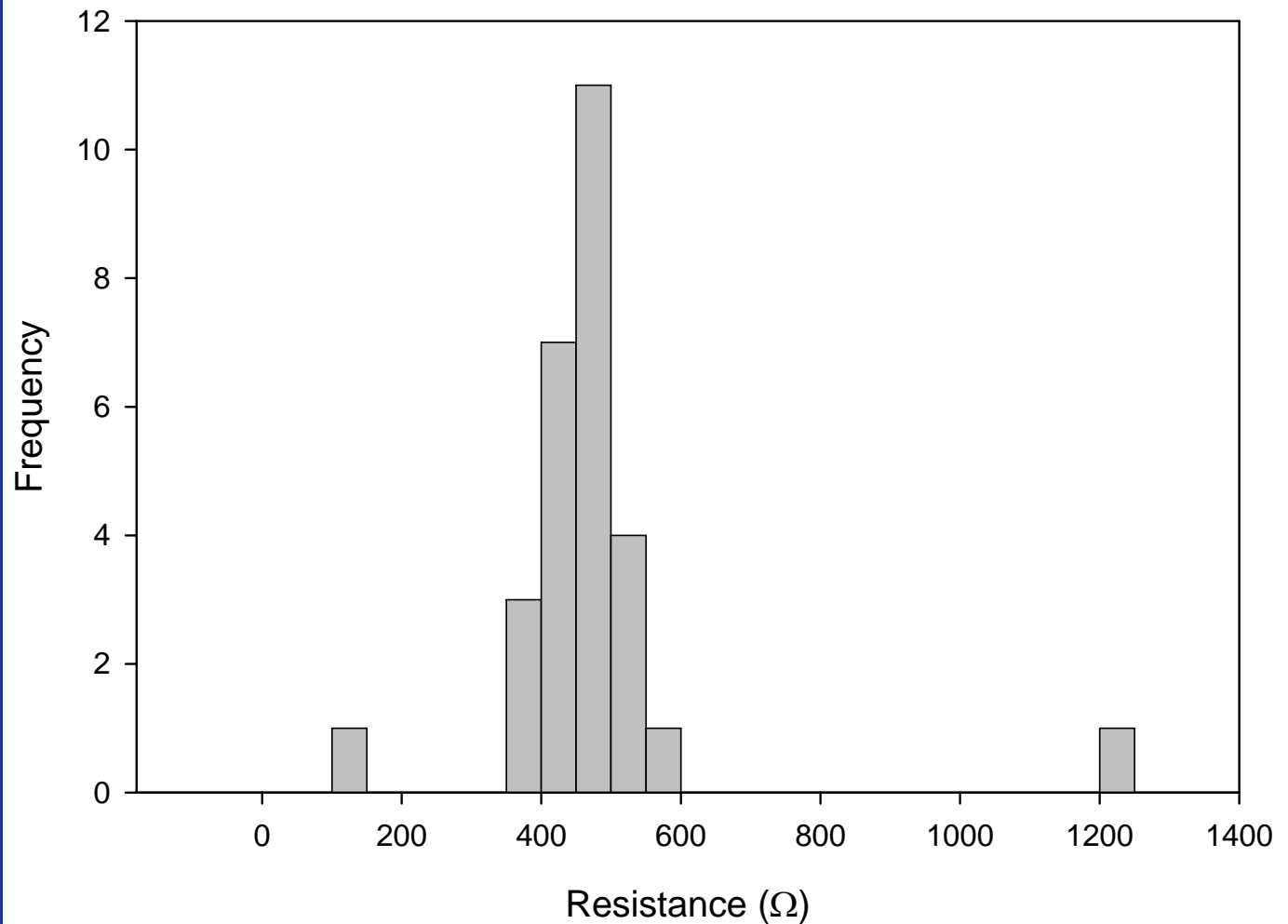
Au dots

PDOT

oxidized wafer

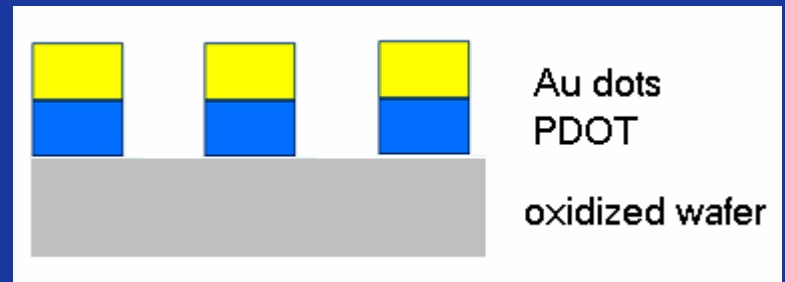
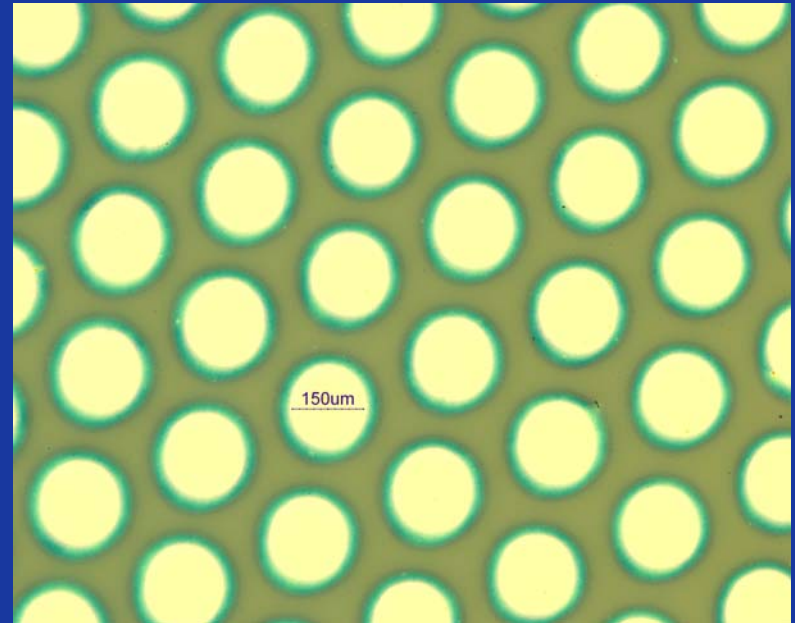
Distribution of Resistances

3, 6, and 12 Hour P-dot Baking Times



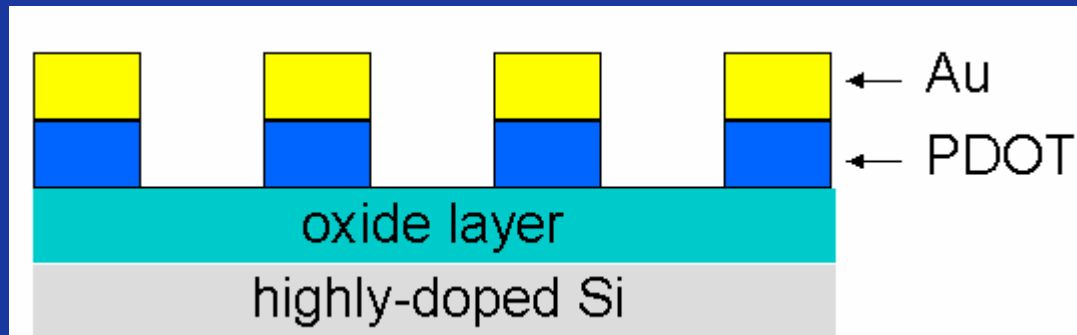
Etching the PDOT

- Reactive Ion Etching (RIE)
 - Oxygen plasma is used to etch the PDOT around the Au dots
 - 2 minutes is sufficient to etch through the PDOT film

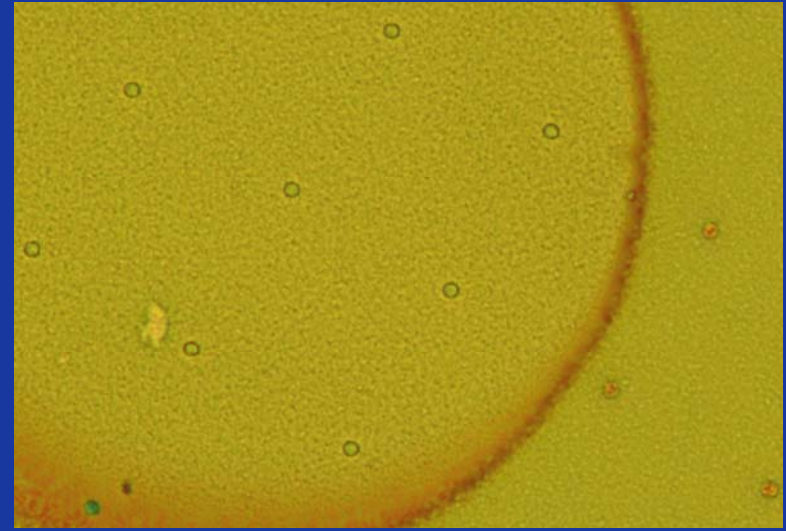
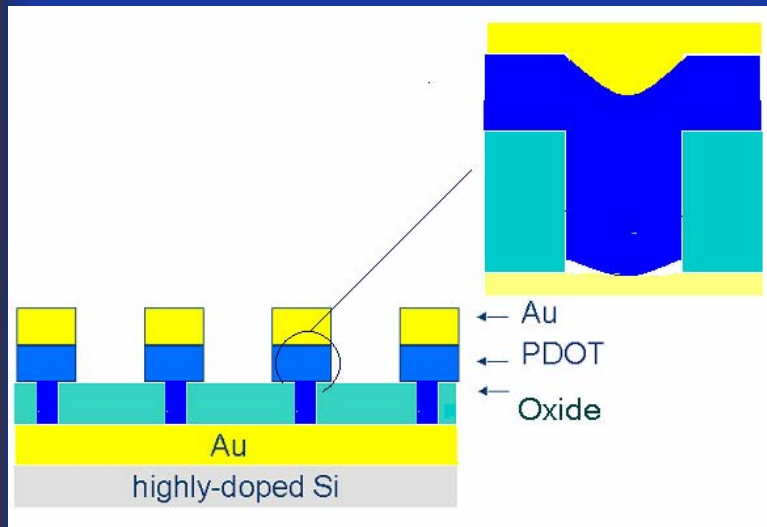


Depositing an Oxide

- Plasma Enhanced Chemical Vapor Deposition (PECVD)
 - Recipe used contains nitrogen, so layer deposited is not pure SiO_2
 - Deposition rate is about $500 \text{ \AA}/\text{min}$
 - 500 \AA layer of oxide deposited onto doped wafer, PDOT was spun on top, Au dots were evaporated on top, and the PDOT was etched



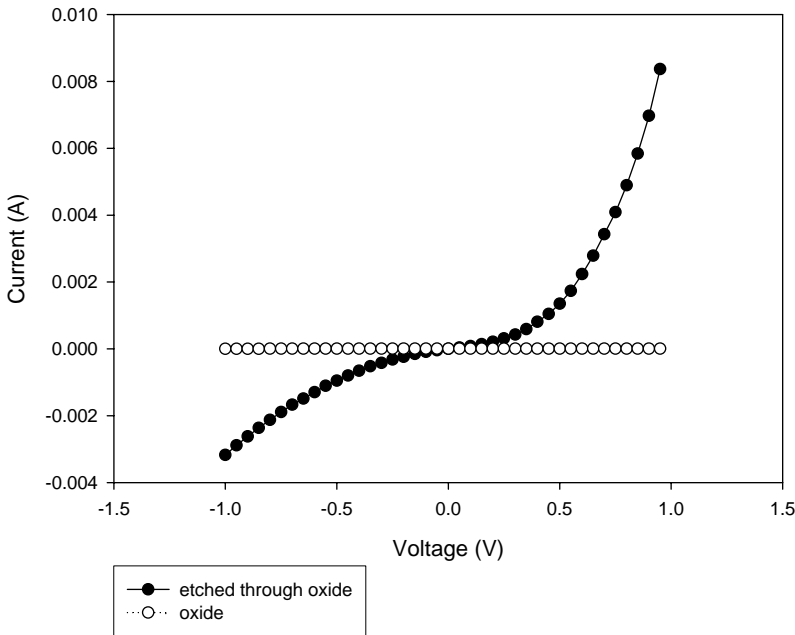
Etching Through the Oxide



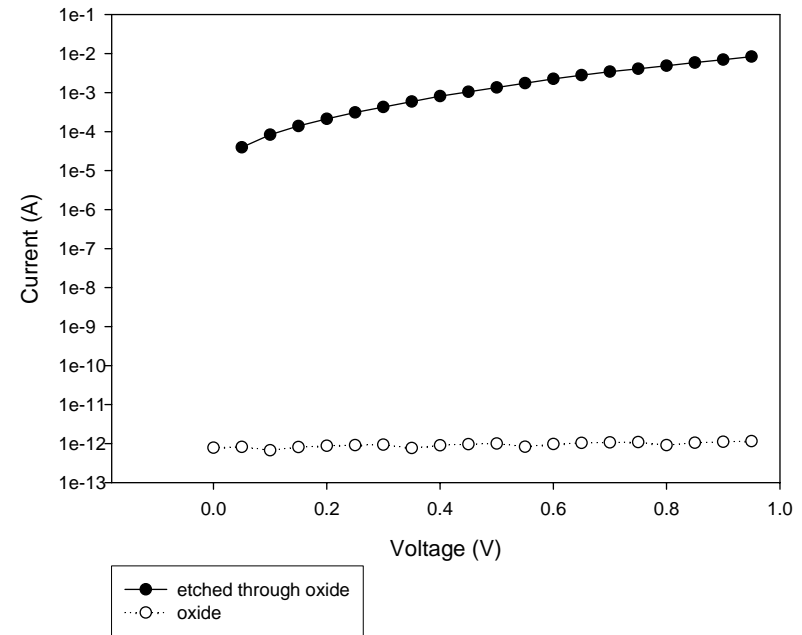
- Oxide layers of 500 Å and 1000 Å deposited onto Au coated wafers
- Nanobuckets etched in oxide using photolithography and RIE
- PDOT spun, Au dots evaporated, and PDOT etched

Current Through Etched and Unetched Oxide

Current Through 1000 Å Oxide



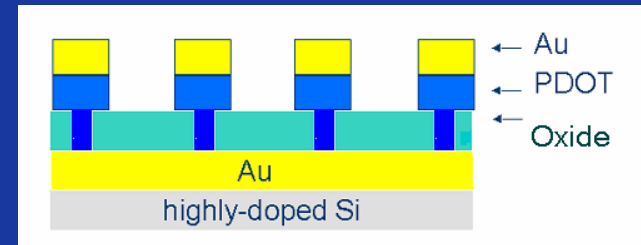
Current Through 1000 Å Oxide



Unetched Oxide



Etched Oxide

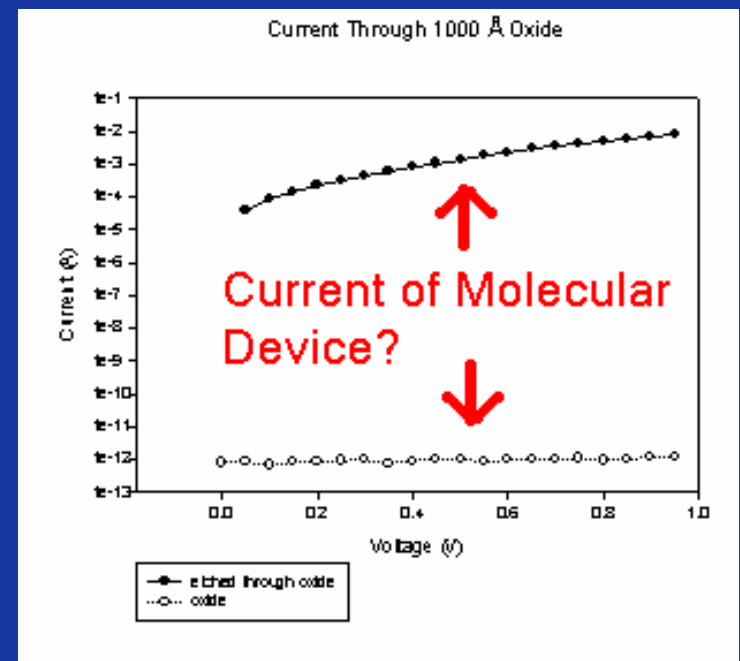
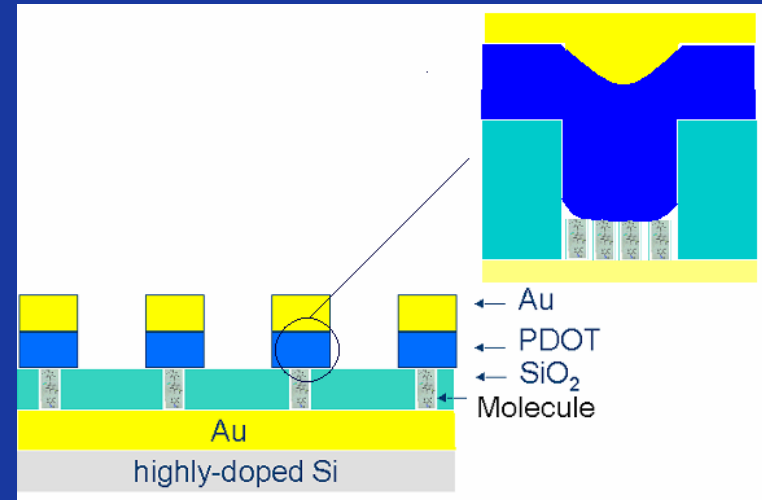


Conclusion

- Processes leading to the the construction of a molecular device were optimized
 - Spinning and curing of PDOT
 - Etching PDOT
 - Depositing an oxide
 - Etching oxide
- A structure ready for the addition of the molecule has been made and the current through the oxide has been measured

Future Work

- Assembling the molecules through holes etched in oxide onto gold
- Measure the current through the molecule



Acknowledgements

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